

## Diode

Fast Switching Emitter Controlled Diode

### IDW30E60

Emitter Controlled Diode series

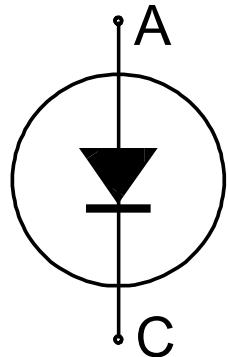
Data sheet

Industrial & Multimarket

## Fast Switching Emitter Controlled Diode

### Features:

- Qualified according to JEDEC for target applications
- 600 V Emitter Controlled technology
- Fast recovery
- Soft switching
- Low reverse recovery charge
- Low forward voltage
- 175 °C junction operating temperature
- Easy paralleling
- Pb-free lead plating; RoHS compliant

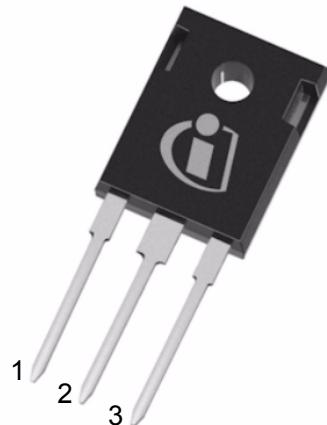


### Applications:

- Switching diode for PFC applications with operating range up to 30kHz

### Package pin definition:

- Pin 1 - not connected
- Pin 2 - cathode
- Pin 3 - anode



### Key Performance and Package Parameters

Type	$V_{f\text{rm}}$	$I_f$	$V_f, T_{vj}=25^\circ\text{C}$	$T_{vj\text{max}}$	Marking	Package
IDW30E60	600V	30A	1.65V	175°C	D30E60	PG-T0247-3

**Table of Contents**

Description .....	2
Table of Contents .....	3
Maximum ratings .....	4
Thermal Resistance .....	4
Electrical Characteristics .....	4
Electrical Characteristics diagrams .....	6
Package Drawing .....	9
Testing Conditions .....	10
Revision History .....	11
Disclaimer .....	11

**Maximum ratings**

Parameter	Symbol	Value	Unit
Repetitive peak reverse voltage	$V_{RRM}$	600	V
Diode forward current, limited by $T_{vjmax}$ $T_C = 25^\circ\text{C}$ $T_C = 115^\circ\text{C}$	$I_F$	60.0 30.0	A
Diode pulsed current, $t_p$ limited by $T_{vjmax}$	$I_{Fpuls}$	90.0	A
Diode surge non repetitive forward current $T_C = 25^\circ\text{C}$ , $t_p = 10.0\text{ms}$ , sine halfwave	$I_{FSM}$	150.0	A
Power dissipation $T_C = 25^\circ\text{C}$	$P_{tot}$	143.0	W
Operating junction temperature	$T_{vj}$	-40...+175	°C
Storage temperature	$T_{stg}$	-55...+150	°C
Soldering temperature, wave soldering 1.6 mm (0.063 in.) from case for 10s		260	°C
Mounting torque, M3 screw Maximum of mounting processes: 3	$M$	0.6	Nm

**Thermal Resistance**

Parameter	Symbol	Conditions	Max. Value	Unit
<b>Characteristic</b>				
Diode thermal resistance, junction - case	$R_{th(j-c)}$		1.05	K/W
Thermal resistance junction - ambient	$R_{th(j-a)}$		40	K/W

**Electrical Characteristic, at  $T_{vj} = 25^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
<b>Static Characteristic</b>						
Diode forward voltage	$V_F$	$I_F = 30.0\text{A}$ $T_{vj} = 25^\circ\text{C}$ $T_{vj} = 175^\circ\text{C}$	- -	1.65 1.60	2.00	V
Reverse leakage current	$I_R$	$V_R = 600\text{V}$ $T_{vj} = 25^\circ\text{C}$ $T_{vj} = 175^\circ\text{C}$	- -	- -	40.0 1000.0	μA

**Electrical Characteristic, at  $T_{vj} = 25^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
<b>Dynamic Characteristic</b>						
Internal emitter inductance measured 5mm (0.197 in.) from case	$L_E$		-	13.0	-	nH

**Switching Characteristic, Inductive Load, at  $T_{vj} = 25^\circ\text{C}$** 

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	

**Diode Characteristic, at  $T_{vj} = 25^\circ\text{C}$** 

Diode reverse recovery time	$t_{rr}$	$T_{vj} = 25^\circ\text{C}$ , $V_R = 400\text{V}$ , $I_F = 30.0\text{A}$ , $dI/dt = 1000\text{A}/\mu\text{s}$	-	143	-	ns
Diode reverse recovery charge	$Q_{rr}$		-	1.20	-	$\mu\text{C}$
Diode peak reverse recovery current	$I_{rrm}$		-	13.0	-	A
Diode peak rate of fall of reverse recovery current during $t_b$	$dI_{rr}/dt$		-	-108	-	$\text{A}/\mu\text{s}$

**Switching Characteristic, Inductive Load, at  $T_{vj} = 175^\circ\text{C}$** 

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	

**Diode Characteristic, at  $T_{vj} = 175^\circ\text{C}$** 

Diode reverse recovery time	$t_{rr}$	$T_{vj} = 175^\circ\text{C}$ , $V_R = 400\text{V}$ , $I_F = 30.0\text{A}$ , $dI/dt = 1000\text{A}/\mu\text{s}$	-	255	-	ns
Diode reverse recovery charge	$Q_{rr}$		-	2.80	-	$\mu\text{C}$
Diode peak reverse recovery current	$I_{rrm}$		-	23.0	-	A
Diode peak rate of fall of reverse recovery current during $t_b$	$dI_{rr}/dt$		-	-108	-	$\text{A}/\mu\text{s}$

## Emitter Controlled Diode series

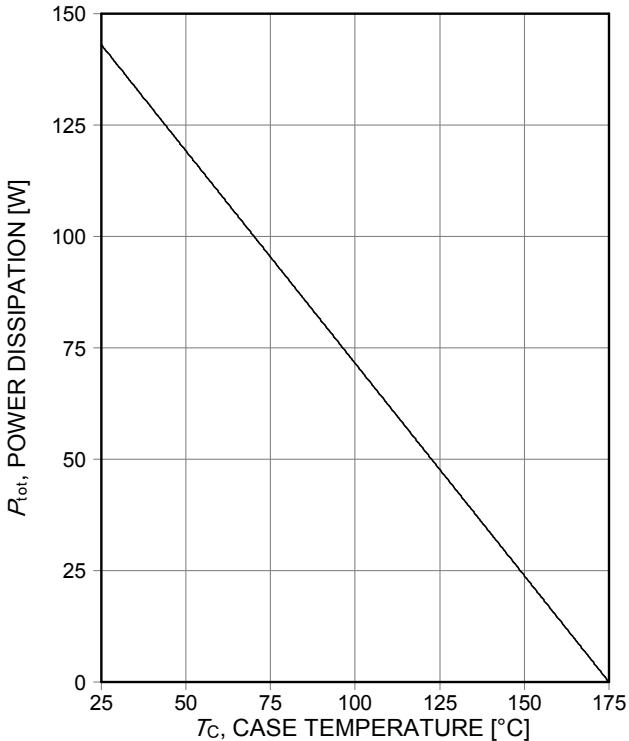


Figure 1. Power dissipation as a function of case temperature  
( $T_j \leq 175^\circ\text{C}$ )

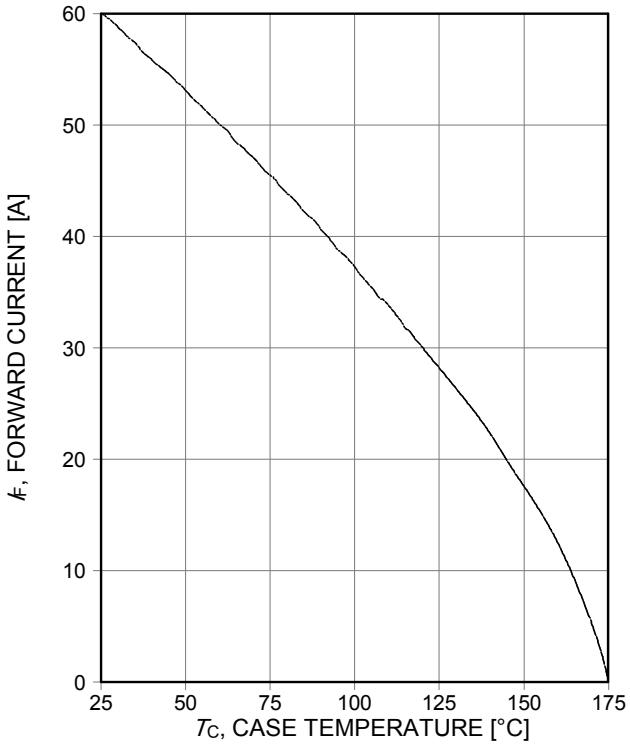


Figure 2. Diode forward current as a function of case temperature  
( $T_j \leq 175^\circ\text{C}$ )

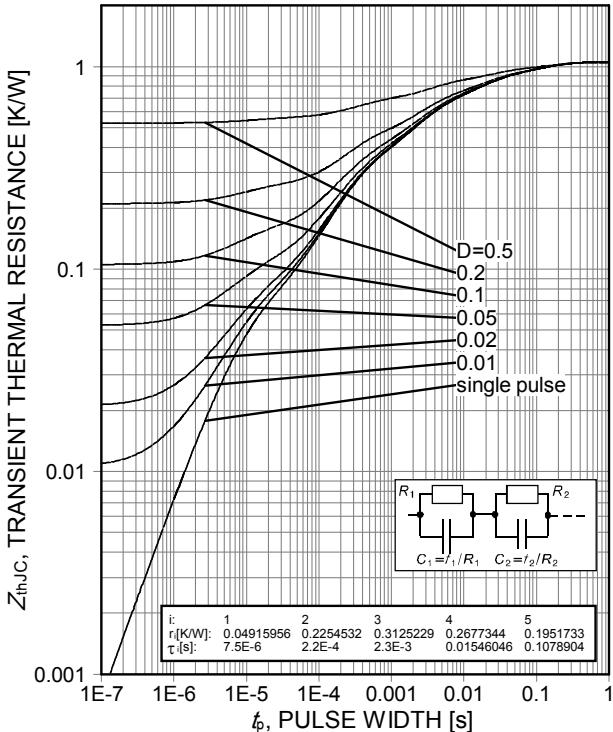


Figure 3. Diode transient thermal impedance as a function of pulse width  
( $D = t_p/T$ )

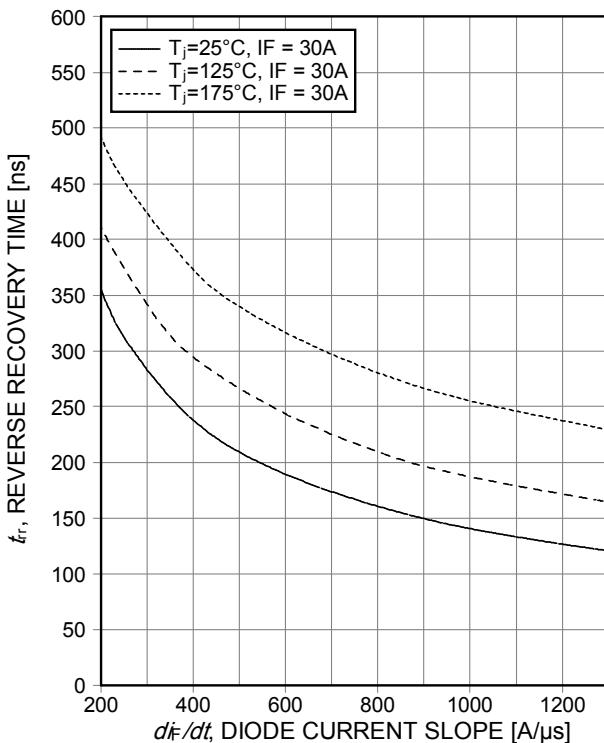
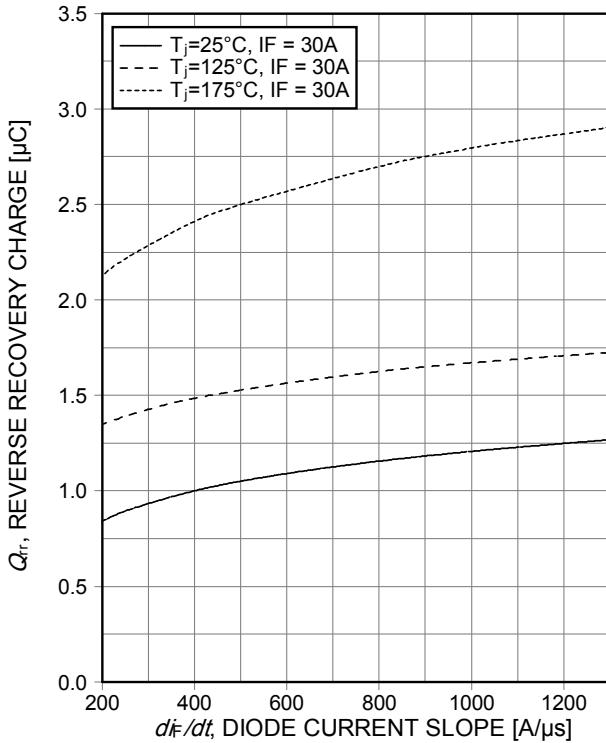
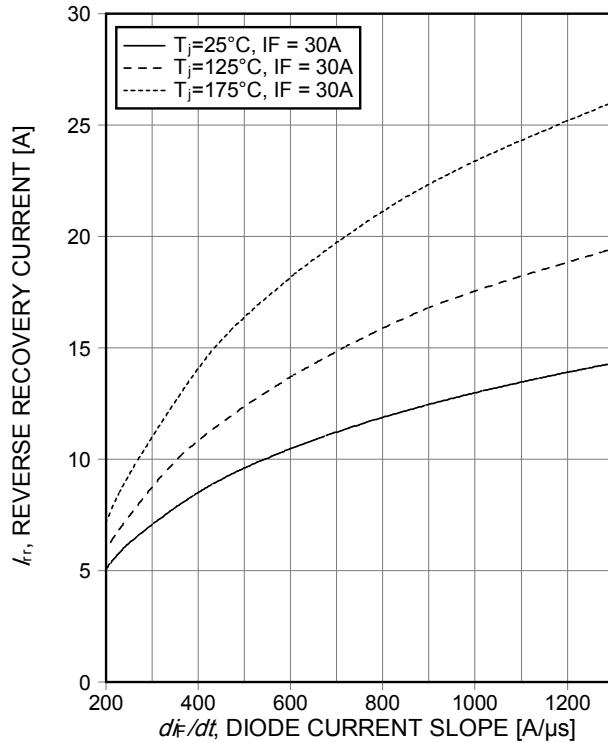


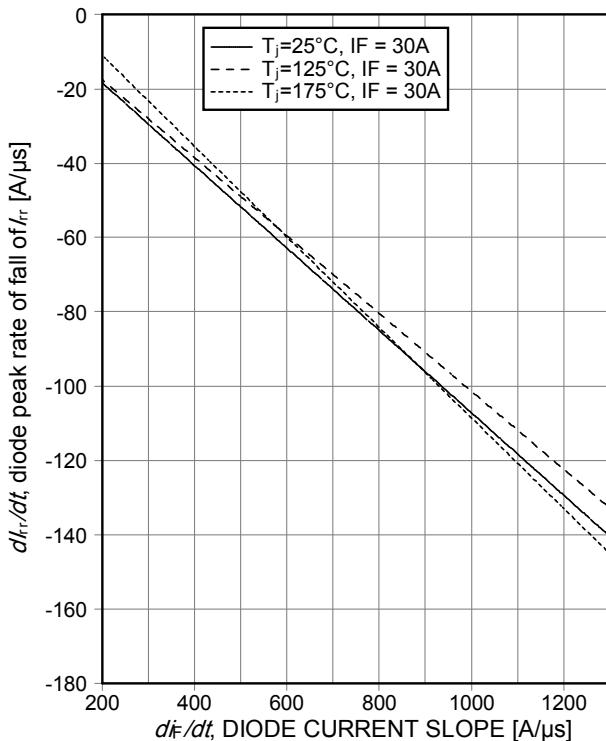
Figure 4. Typical reverse recovery time as a function of diode current slope  
( $V_R=400\text{V}$ ,  $I_F=30\text{A}$ , Dynamic test circuit in Figure E)



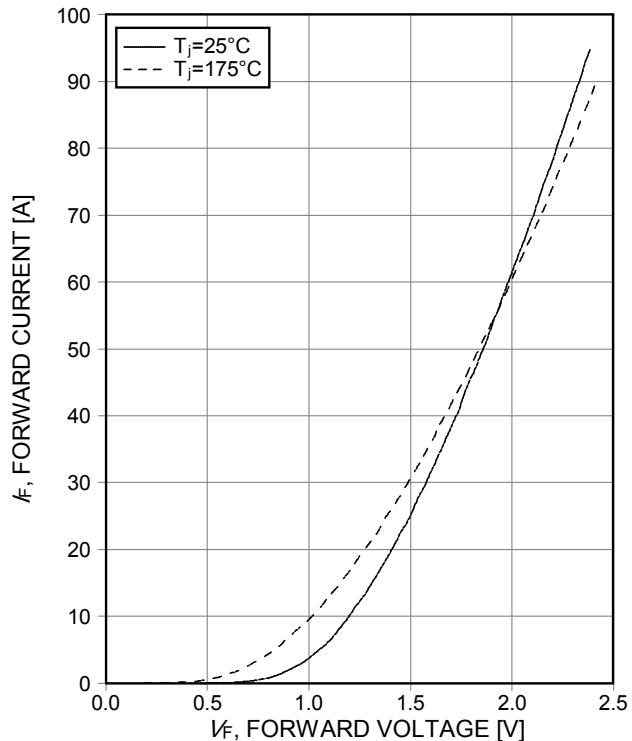
**Figure 5. Typical reverse recovery charge as a function of diode current slope**  
( $V_R=400V$ ,  $I_F=30A$ , Dynamic test circuit in Figure E)



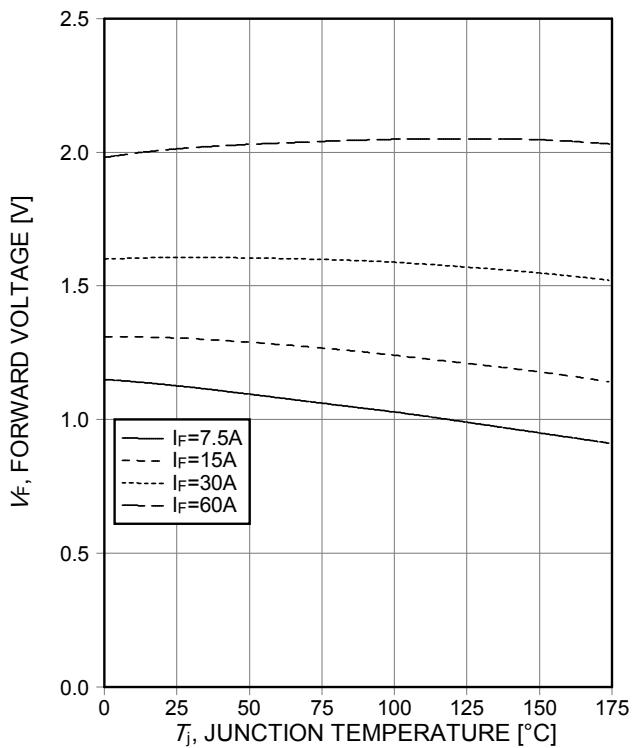
**Figure 6. Typical reverse recovery current as a function of diode current slope**  
( $V_R=400V$ ,  $I_F=30A$ , Dynamic test circuit in Figure E)



**Figure 7. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope**  
( $V_R=400V$ ,  $I_F=30A$ , Dynamic test circuit in Figure E)

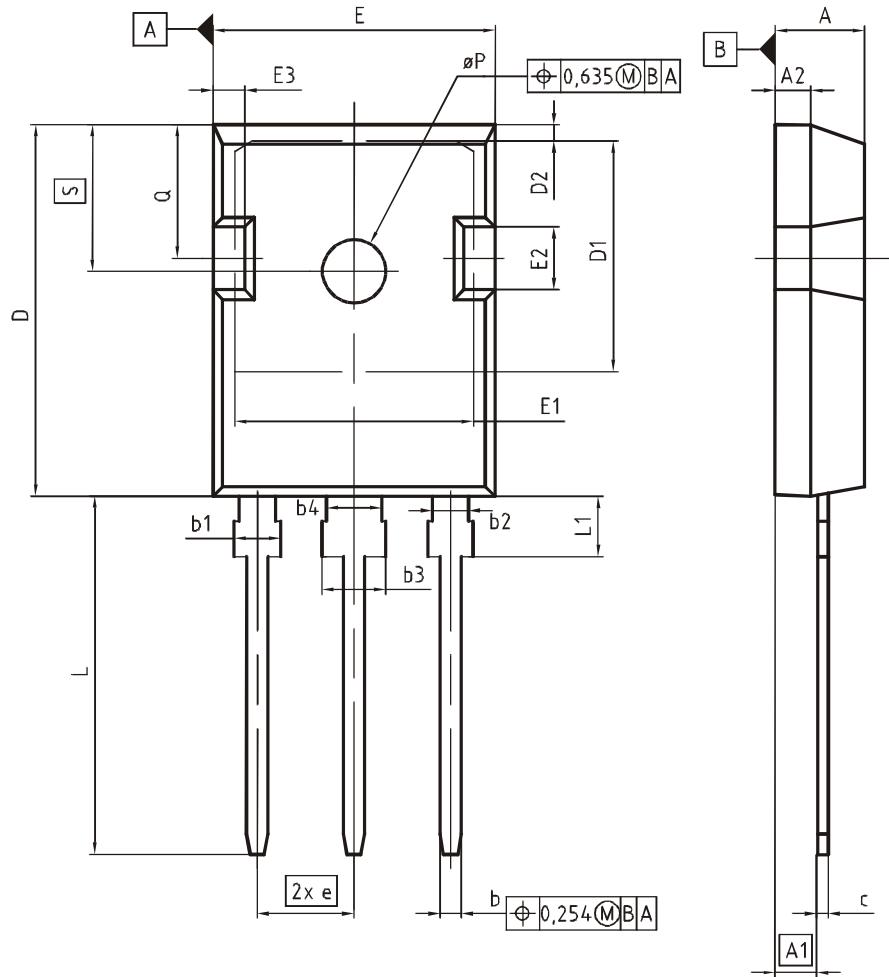


**Figure 8. Typical diode forward current as a function of forward voltage**



**Figure 9. Typical diode forward voltage as a function of junction temperature**

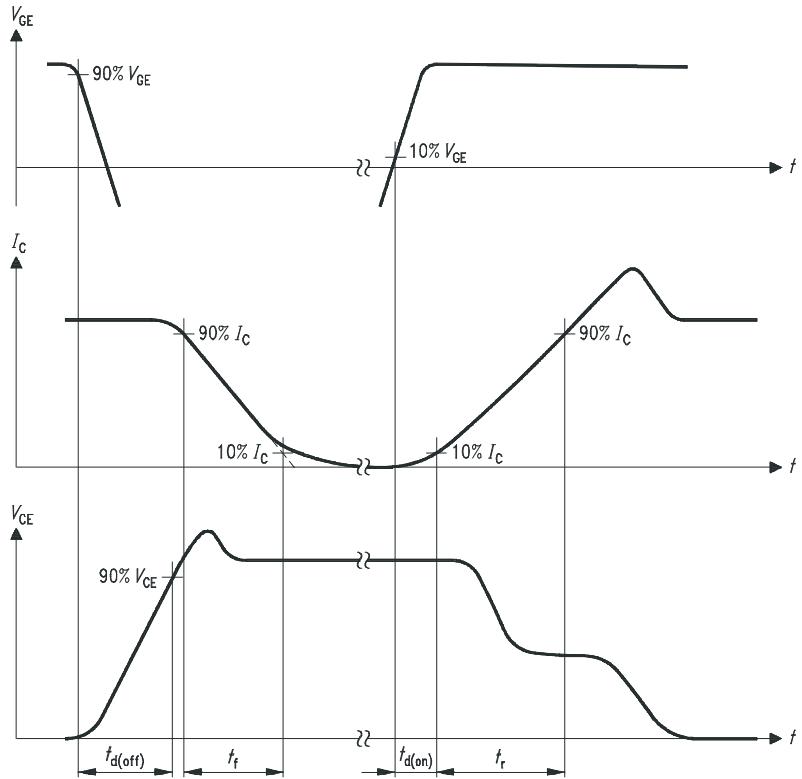
## PG-T0247-3



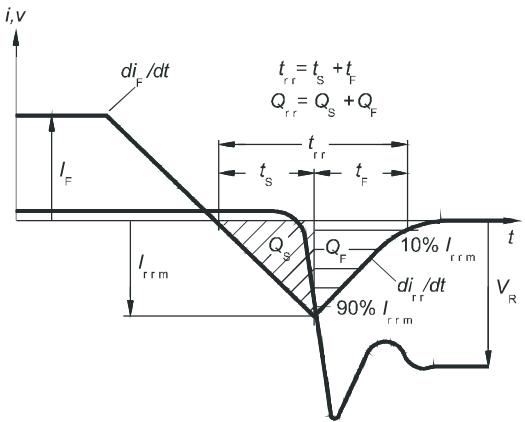
DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	0.190	0.205
A1	2.27	2.54	0.089	0.100
A2	1.85	2.16	0.073	0.085
b	1.07	1.33	0.042	0.052
b1	1.90	2.41	0.075	0.095
b2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
b4	2.87	3.13	0.113	0.123
c	0.55	0.68	0.022	0.027
D	20.80	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.95	1.35	0.037	0.053
E	15.70	16.13	0.618	0.635
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.00	2.60	0.039	0.102
e	5.44 (BSC)		0.214 (BSC)	
N	3		3	
L	19.80	20.32	0.780	0.800
L1	4.10	4.47	0.161	0.176
øP	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

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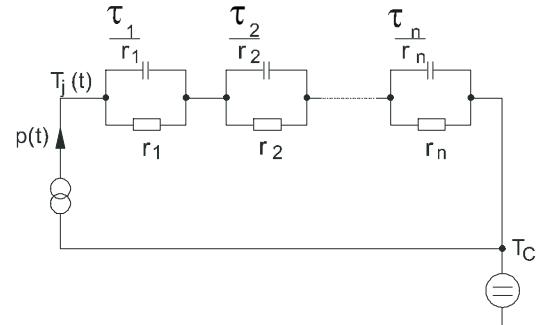
## Emitter Controlled Diode series



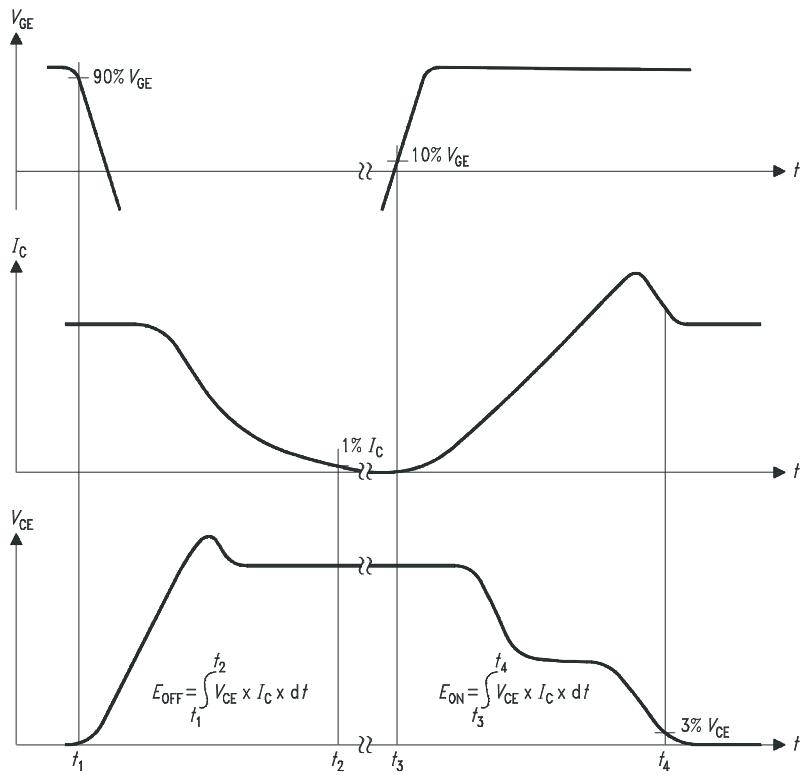
**Figure A. Definition of switching times**



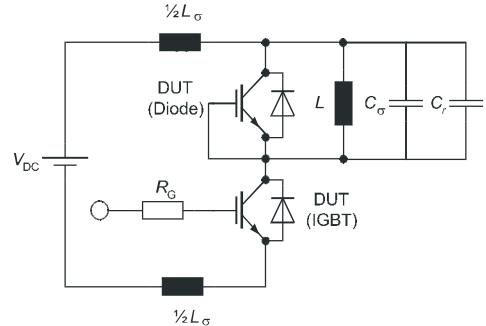
**Figure C. Definition of diodes switching characteristics**



**Figure D. Thermal equivalent circuit**



**Figure B. Definition of switching losses**



**Figure E. Dynamic test circuit**  
Parasitic inductance  $L_\sigma$ ,  
Parasitic capacitor  $C_\sigma$ ,  
Relief capacitor  $C_r$   
(only for ZVT switching)

**Revision History**

IDW30E60

**Revision: 2011-11-10, Rev. 1.1****Previous Revision**

Revision	Date	Subjects (major changes since last revision)
1.1	2011-11-10	Preliminary data sheet

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